

HEARING AID COMPATIBILITY

Applicant Name:

Samsung Electronics Co., Ltd.
129, Samsung-ro, Maetan dong,
Yeongtong-gu, Suwon-si
Gyeonggi-do 16677, Korea

Date of Testing:

10/28/2019 - 10/29/2019

Test Site/Location:

PCTEST Lab, Columbia, MD, USA

Test Report Serial No.:

1M1910220168-01.A3L

Date of Issue:

10/31/2019

FCC ID:

A3LSMJ337P

APPLICANT:

SAMSUNG ELECTRONICS CO., LTD.

Scope of Test:

Application Type:

FCC Rule Part(s):

HAC Standard:

Audio Band Magnetic Testing (T-Coil)

Class II Permissive Change

CFR §20.19(b)

ANSI C63.19-2011

285076 D01 HAC Guidance v05

285076 D02 T-Coil testing for CMRS IP v03

DUT Type:

Model:

Test Device Serial No.:

Class II Permissive Change(s):

Portable Handset

SM-J337P

Pre-Production Sample [S/N: 58046]

See FCC Change Document

C63.19-2011 HAC Category:

T4 (SIGNAL TO NOISE CATEGORY)

This report and category pertain only to the Voice over LTE services supported by this wireless portable device. Please refer to the original certification technical report (S/N: 1M1803090037-11-R1.A3L) for data on other modes supported by this device. This wireless portable device has been shown to be hearing-aid compatible for Voice over LTE services, under the above rated category, specified in ANSI/IEEE Std. C63.19-2011 and has been tested in accordance with the specified measurement procedures. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. Test results reported herein relate only to the item(s) tested. North America bands only.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.


Randy Ortanez
President



FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 1 of 47

TABLE OF CONTENTS

1.	INTRODUCTION	3
2.	DUT DESCRIPTION.....	4
3.	ANSI C63.19-2011 PERFORMANCE CATEGORIES	5
4.	METHOD OF MEASUREMENT	7
5.	VOLTE TEST SYSTEM SETUP AND DUT CONFIGURATION	16
6.	T-COIL TEST SUMMARY	20
7.	MEASUREMENT UNCERTAINTY	26
8.	EQUIPMENT LIST.....	27
9.	TEST DATA.....	28
10.	CALIBRATION CERTIFICATES.....	35
11.	CONCLUSION.....	42
12.	REFERENCES	43
13.	TEST SETUP PHOTOGRAPHS	45

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 2 of 47

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REV 3.3.M

08/13/2019

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1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide and 30 million people in the United States suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.

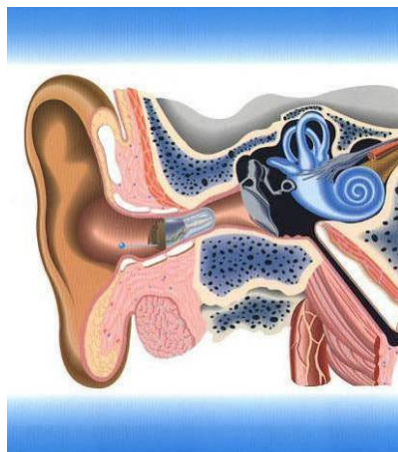


Figure 1-1 Hearing Aid *in-vitu*

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 3 of 47

2. DUT DESCRIPTION



FCC ID: A3LSMJ337P
 Applicant: Samsung Electronics Co., Ltd.
 129, Samsung-ro, Maetan dong,
 Yeongtong-gu, Suwon-si
 Gyeonggi-do 16677, Korea
 Model: SM-J337P
 Serial Number: 58046
 HW Version: J337PVPU4BSJ2
 SW Version: J337P.06
 Antenna: Internal Antenna
 DUT Type: Portable Handset

Table 2-1
A3LSMJ337P HAC Air Interfaces

Air-Interface	Band (MHz)	Type Transport	HAC Tested	Simultaneous But Not Tested	Name of Voice Service	Audio Codec Evaluated
CDMA	835	VO	No ³	Yes: WIFI or BT	CMRS Voice ¹	EVRC
	1900	VD	No ³	Yes: WIFI or BT	Google Duo ²	OPUS
	EvDO	VD	No ³	Yes: WIFI or BT	Google Duo ²	OPUS
GSM	850	VO	No ³	Yes: WIFI or BT	CMRS Voice ¹	EFR
	1900	VD	No ³	Yes: WIFI or BT	Google Duo ²	OPUS
	GPRS/EDGE	VD	No ³	Yes: WIFI or BT	Google Duo ²	OPUS
UMTS	850	VD	No ³	Yes: WIFI or BT	CMRS Voice ¹	NB AMR
	1700	VD	No ³	Yes: WIFI or BT	Google Duo ²	OPUS
	1900	VD	No ³	Yes: WIFI or BT	Google Duo ²	OPUS
LTE (FDD)	700 (B12)	VD	Yes	Yes: WIFI or BT	VoLTE ¹ , Google Duo ²	VoLTE: NB AMR, WB AMR Google Duo: OPUS
	850 (B5)					
	850 (B26)					
	1700 (B4)					
	1900 (B2)					
	1900 (B25)					
LTE (TDD)	2600 (B41)	VD	Yes	Yes: WIFI or BT	VoLTE ¹ , Google Duo ²	VoLTE: NB AMR, WB AMR Google Duo: OPUS
WIFI	2450	VD	No ³	Yes: CDMA, GSM, UMTS, or LTE	VoWIFI ³ , Google Duo ²	VoWIFI: NB AMR, WB AMR Google Duo: OPUS
	5200 (U-NII 1)					
	5300 (U-NII 2A)					
	5500 (U-NII 2C)					
BT	5800 (U-NII 3)	DT	No	Yes: CDMA, GSM, UMTS, or LTE	N/A	N/A
	2450					

Type Transport
 VO = Voice Only
 DT = Digital Data - Not intended for Voice Services
 VD = CMRS and/or IP Voice over Data Transport

Notes:
 1. Reference level in accordance with 7.4.2.1 of ANSI C63.19-2011 and July 2012 C63 VoLTE Interpretation.
 2. Reference level is -20dBm0 in accordance with FCC KDB 285076 D02
 3. This report only pertains to Voice Over LTE services. Please refer to the original certification technical report (S/N: 1M1803090037-11-R1.A3L) for data on other modes supported by this device.

I. LTE Band Selection

This device supports the following pairs of LTE bands with similar frequencies: LTE B25 & B2 and B26 & B5. These pairs of LTE bands have the same target powers and share the same transmission paths. Since the supported frequency span for the smaller LTE bands are completely covered by the larger LTE bands, only the larger LTE bands (LTE B25 and B26) were evaluated for hearing-aid compliance.

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 4 of 47

3. ANSI C63.19-2011 PERFORMANCE CATEGORIES

I. MAGNETIC COUPLING

Axial and Radial Field Intensity

All orientations of the magnetic field, in the axial and radial position along the measurement plane shall be ≥ -18 dB(A/m) at 1 kHz in a 1/3 octave band filter per §8.3.1.

Frequency Response

The frequency response of the axial component of the magnetic field shall follow the response curve specified in EIA RS-504-1983, over the frequency range 300 Hz – 3000 Hz per §8.3.2.

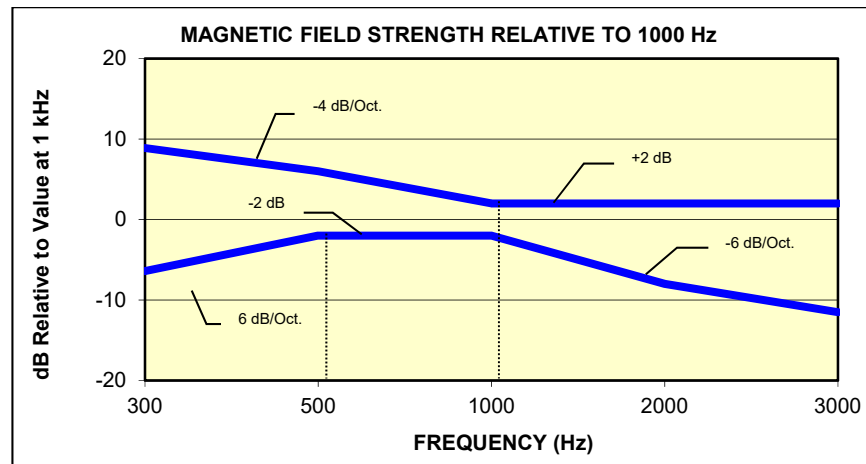


Figure 3-1
Magnetic field frequency response for Wireless Devices with an axial field ≤ -15 dB(A/m) at 1 kHz

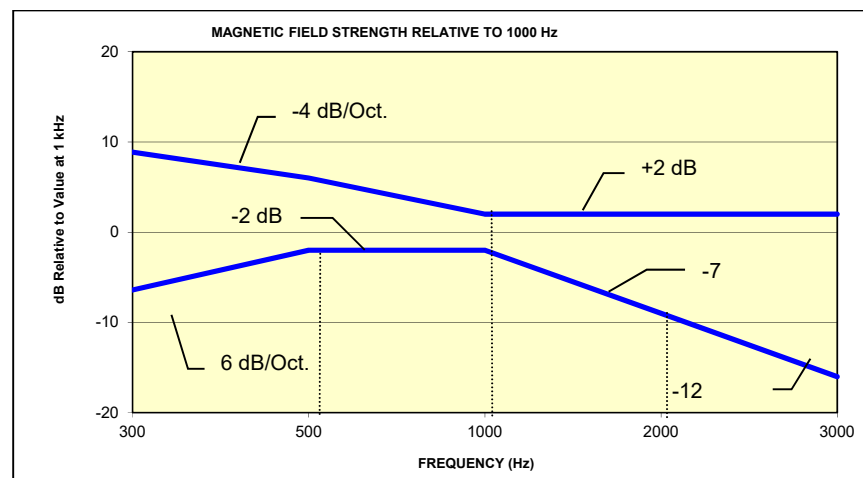


Figure 3-2
Magnetic Field frequency response for wireless devices with an axial field that exceeds -15 dB(A/m) at 1 kHz

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 5 of 47

Signal Quality

The table below provides the signal quality requirement for the intended audio magnetic signal from a wireless device. Only the RF immunity of the hearing aid is measured in T-coil mode. It is assumed that a hearing aid can have no immunity to an interference signal in the audio band, which is the intended reception band for this mode. The only criterion that can be measured is the RF immunity in T-coil mode. This is measured using the same procedure as the audio coupling mode at the same levels.

The signal quality of the axial and radial components of the magnetic field was used to determine the T-coil mode category.

Category	Telephone RF Parameters
	Wireless Device Signal Quality [(Signal + Noise)-to-noise ratio in dB]
T1	0 to 10 dB
T2	10 to 20 dB
T3	20 to 30 dB
T4	> 30 dB

Table 3-1
Magnetic Coupling Parameters

Note: The FCC limit for SNNR is 20dB and the test data margins will indicate a margin from the FCC limit for compliance.

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 6 of 47

4. METHOD OF MEASUREMENT

I. Test Setup

The equipment was connected as shown in an acoustic/RF hemi-anechoic chamber:

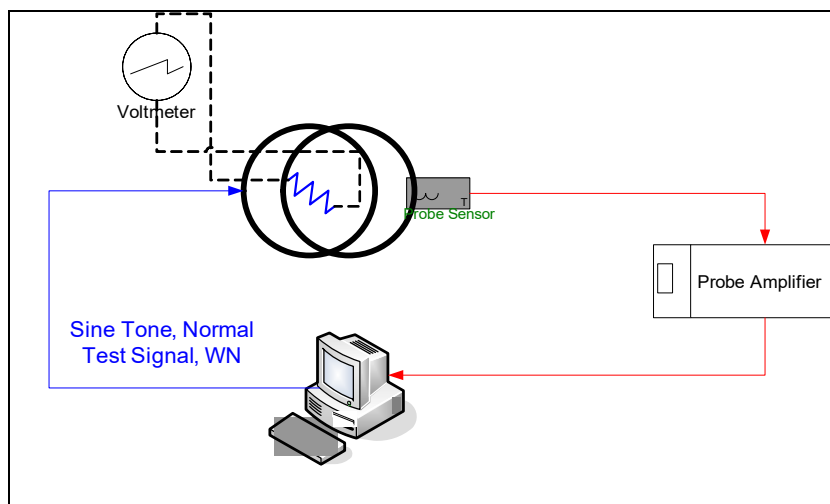


Figure 4-1
Validation Setup with Helmholtz Coil

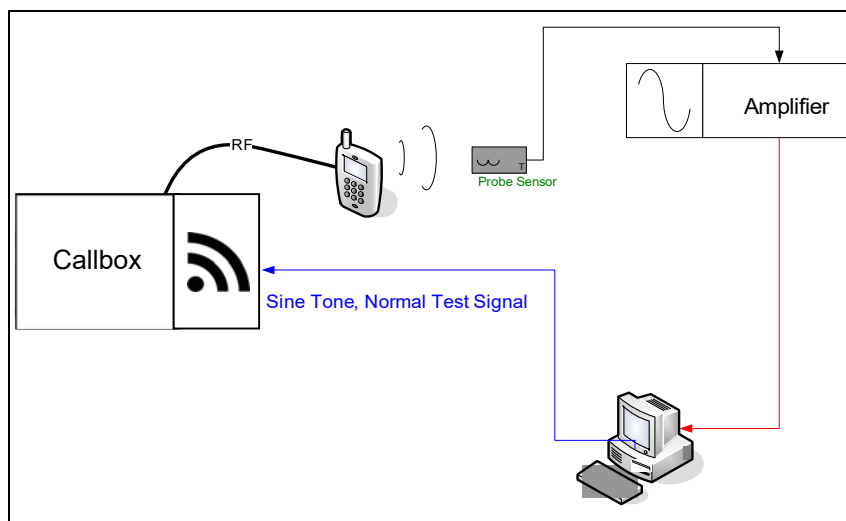


Figure 4-2
T-Coil Test Setup

FCC ID: A3LSMJ337P	PCTEST ENGINEERING LABORATORY, INC.	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 7 of 47

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08/13/2019

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II. Scanning Mechanism

Manufacturer:	TEM
Accuracy:	± 0.83 cm/meter
Minimum Step Size:	0.1 mm
Maximum speed	6.1 cm/sec
Line Voltage:	115 VAC
Line Frequency:	60 Hz
Material Composite:	Delrin (Acetal)
Data Control:	Parallel Port
Dynamic Range (X-Y-Z):	45 x 31.75 x 47 cm
Dimensions:	36" x 25" x 38"
Operating Area:	36" x 49" x 55"
Reflections:	< -20 dB (in anechoic chamber)

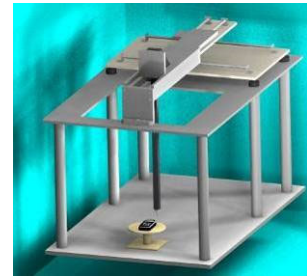


Figure 4-3
RF Near-Field Scanner

III. 3GPP2 Normal Test Signal (Speech)

Manufacturer:	3GPP2 (TIA 1042 §3.3.1)
	Modified-IRS weighted, multi-talker speech signal, 4 Male and 4
Stimulus Type:	Female speakers (alternating)
Single Sample Duration:	51.62 seconds
Activity Level:	77.4%

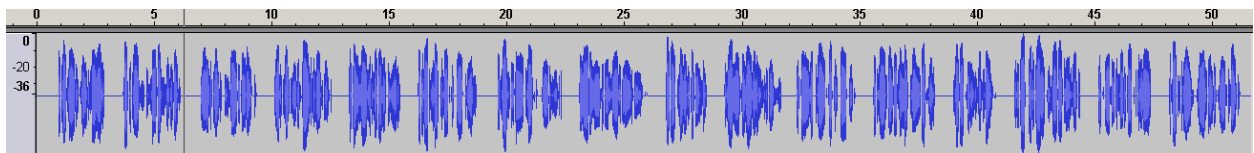
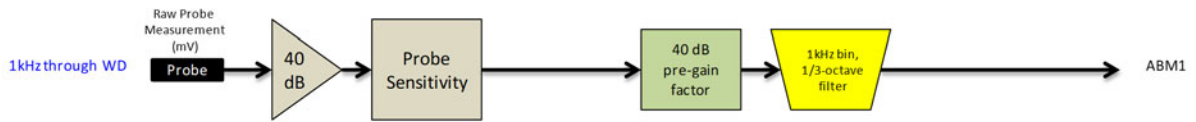


Figure 4-4
Temporal Characteristic of Normal Test Signal

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 8 of 47

ABM1 Measurement Block Diagram:



ABM2 Measurement Block Diagram:

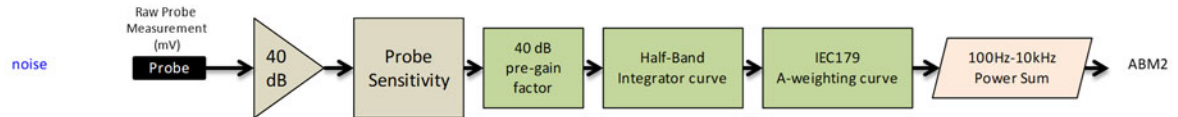


Figure 4-5 Magnetic Measurement Processing Steps

IV. Test Procedure

1. Ambient Noise Check per C63.19 §7.3.1
 - a. Ambient interference was monitored using a Real-Time Analyzer between 100-10,000 Hz with 1/3 octave filtering.
 - b. “A-weighting” and Half-Band Integration was applied to the measurements.
 - c. Since this measurement was measured in the same method as ABM2 measurements, this level was verified to be more than 10 dB below the lowest measurement signal (which is the highest ABM2 measurement for a T4 WD). Therefore the maximum noise level for a T4 WD with an ABM1 = -18 dBA/m is:

$$-18 - 30 - 10 = -58 \text{ dBA/m}$$
2. Measurement System Validation (See Figure 4-1)
 - a. The measurement system including the probe, pre-amplifier and acquisition system were validated as an entire system to ensure the reliability of test measurements.
 - b. ABM1 Validation
 The magnetic field at the center of the Helmholtz coil is given by the equation (per C63.19 Annex D.10.1):

$$H_c = \frac{NI}{r\sqrt{1.25^3}} = \frac{N\left(\frac{V}{R}\right)}{r\sqrt{1.25^3}}$$

Where H_c = magnetic field strength in amperes per meter

N = number of turns per coil

For the Helmholtz Coil, $N=20$; $r=0.13\text{m}$; $R=10.193\Omega$ and using $V=29\text{mV}$:

$$H_c = \frac{20 \cdot \left(\frac{0.029}{10.193}\right)}{0.13 \cdot \sqrt{1.25^3}} = 0.316 \text{ A/m} \approx -10 \text{ dB(A/m)}$$

Therefore a pure tone of 1kHz was applied into the coils such that 29mV was observed across the resistor. The voltmeter used for measurement was verified to be capable of measurements in the audio band range. This theoretically generates an expected field of -10 dB(A/m) in the center of the Helmholtz coil which was used to validate the probe measurement at -10dB(A/m). This was verified to be within ± 0.5 dB of the -10dB(A/m) value (see Page 24).

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 9 of 47

c. Frequency Response Validation

The frequency response through the Helmholtz Coil was verified to be within 0.5 dB relative to 1kHz, between 300 – 3000 Hz using the Normal signal as shown below:

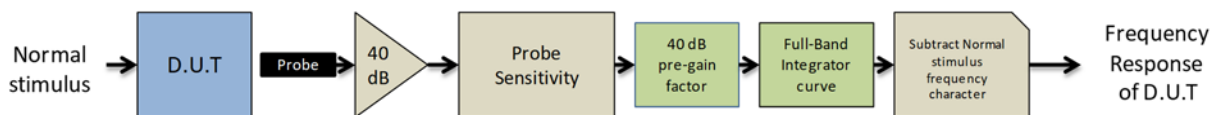


Figure 4-6 Frequency Response Validation

d. ABM2 Measurement Validation

WD noise measurements are filtered with A-weighting and Half-Band Integration over a frequency range of 100Hz – 10kHz to process ABM2 measurements. Below is the verification of the system processing A-weighting and Half-Band integration between system input to output within 0.5 dB of the theoretical result:

Table 4-1
ABM2 Frequency Response Validation

f (Hz)	HBI, A - Measured (dB re 1kHz)	HBI, A - Theoretical (dB re 1kHz)	dB Var.
100	-16.180	-16.170	-0.010
125	-13.257	-13.250	-0.007
160	-10.347	-10.340	-0.007
200	-8.017	-8.010	-0.007
250	-5.925	-5.920	-0.005
315	-4.045	-4.040	-0.005
400	-2.405	-2.400	-0.005
500	-1.212	-1.210	-0.002
630	-0.349	-0.350	0.001
800	0.071	0.070	0.001
1000	0.000	0.000	0.000
1250	-0.503	-0.500	-0.003
1600	-1.513	-1.510	-0.003
2000	-2.778	-2.780	0.002
2500	-4.316	-4.320	0.004
3150	-6.166	-6.170	0.004
4000	-8.322	-8.330	0.008
5000	-10.573	-10.590	0.017
6300	-13.178	-13.200	0.022
8000	-16.241	-16.270	0.029
10000	-19.495	-19.520	0.025

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 10 of 47

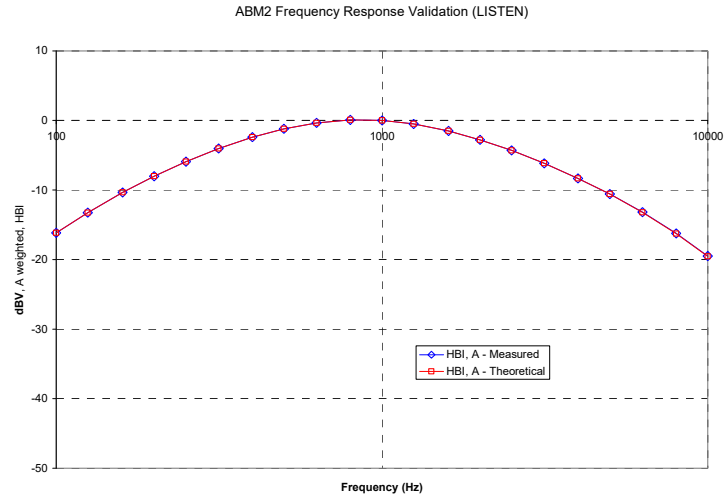


Figure 4-7
ABM2 Frequency Response Validation

The ABM2 result is a power sum from 100Hz to 10kHz with half-band integration and A-weighting. To verify the power sum measurement, a power sum over the full band was measured and verified to track with the source level (See Figure 4-8). Therefore the setup in this step was used to verify the power sum post-processing for ABM2 measurements. See below block diagram:

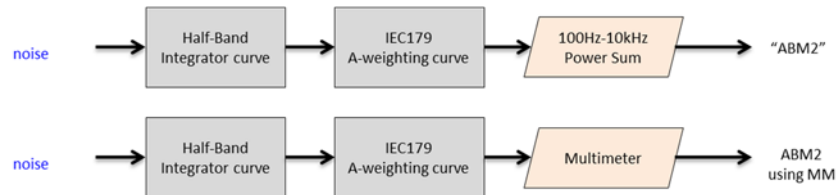


Figure 4-8
ABM2 Validation Block Diagram

The power summed output results for a known input were compared to the multi-meter results to verify any deviation in the post-processing implemented with the power-sum.

Table 4-2
ABM2 Power Sum Validation

WN Input (dBV)	Power Sum (dBV)	Multimeter-Full (dBV)	Dev (dB)
-60	-60.36	-60.2	0.16
-50	-50.19	-50.13	0.06
-40	-40.14	-40.03	0.11
-30	-30.13	-30.01	0.12
-20	-20.12	-20	0.12
-10	-10.14	-10	0.14

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 11 of 47

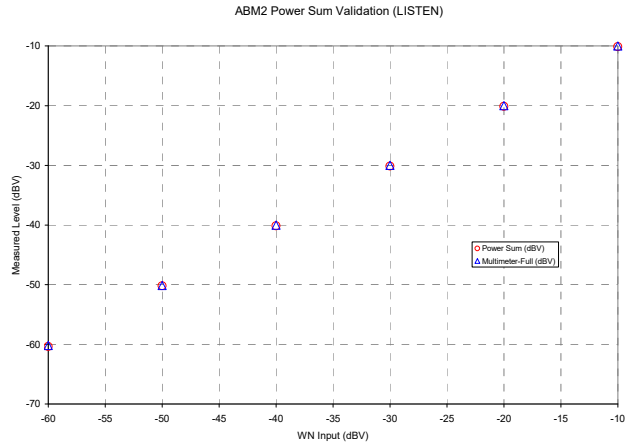


Figure 4-9
ABM2 Power Sum Validation

3. Measurement Test Setup

a. Fine scan above the WD (TEM)

- i. A multitone signal was applied to the handset such that the phone acoustic output was stable within 1dB over the probe settling time and with the acoustic output level at the C63.19 specified levels (below). The measurement step size was in 2 mm increments at a distance of 10 mm between the surface of the wireless device as shown below (note that in Figure 4-11, the grid is not to scale but merely a graphical representation of the coordinate system in use):

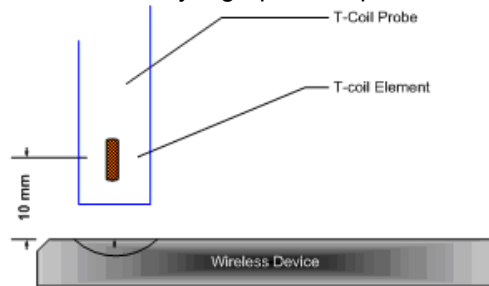


Figure 4-10
Measurement Distance

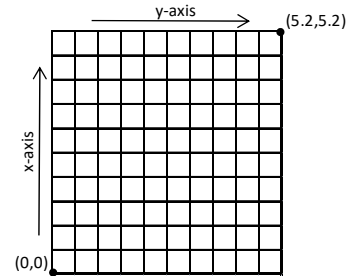


Figure 4-11
Measurement Grid

- ii. After scanning, the planar field maximum point was determined. The position of the probe was moved to this location to setup the test using the SoundCheck system.
- iii. These steps were repeated for all T-coil orientations (axial and radial) per Figure 4-13 after a T-coil orientation was fully measured with the SoundCheck system.
- b. Speech Signal Setup to Base Station Simulator
 - i. See Section 5 for more information regarding CMW500 audio level settings for Voice Over LTE (VoLTE).
- c. Real-Time Analyzer (RTA)
 - i. The Real-Time Analyzer was configured to analyze measurements using 1/3 Octave band weighted filtering.
- d. WD Radio Configuration Selection
 - i. The device was chosen to be tested in the worst-case ABM2 condition (LTE configuration information can be found in Section 5.)

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 12 of 47

4. Signal Quality Data Analysis
 - a. Narrow-band Magnetic Intensity
 - i. The standard specifies a 1kHz 1/3 octave band minimum field intensity for a sine tone. The ABM1 measurements were evaluated at 1kHz with 1/3 octave band filtering over an averaged period of 10 seconds.
 - b. Frequency Response
 - i. The appropriate frequency response curve was measured to curves in Figure 3-1 or Figure 3-2 between 300 – 3000 Hz using digital linear averaging (limit lines chosen according to measurement found in step 4a). A linear average over 3x the length of the artificial voice signal (3x sampling) was performed. A 10 second delay was configured in the measurement process of the stimulus to ensure handset vocoder latency effects and echo cancellation devices (if any) were appropriately stabilized during measurements.
 - ii. The appropriate post-processing was applied according to the system processing chain illustrated in Figure 4-6. All R10 frequencies were plotted with respect to 0dB at 1kHz value and aligned with respect to the EIA-504 mask.
 - iii. The margin is represented by the closest measured data point on the curve to the EIA-504 limit lines, in dB.
 - c. Signal Quality Index
 - i. Ensuring the WD was at maximum RF power, maximum volume, backlight off, display on, maximum contrast setting, keypad lights on (when possible) with no audio signal through the vocoder, the WD was measured over at least 100 Hz – 10,000 Hz, maximized over 5 seconds with a 50ms sample time for the ABM2 measurement (5 second time period is used in noise measurements under standards such as IEEE 269, etc.).
 - ii. After applying half-band integration and A-weighting to the result, a power sum was applied over each 1/3 octave bandwidth frequency for an ABM2 value.
 - iii. This result was subtracted from the ABM1 result in step a, to obtain the Signal Quality.

V. Test Setup

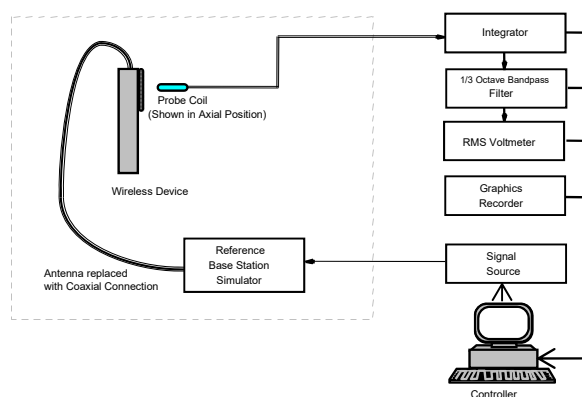


Figure 4-12
Audio Magnetic Field Test Setup

Environmental conditions such as temperature and relative humidity are monitored to ensure there are no impacts on system specifications. Proper voltage and power line frequency conditions are maintained with three phase power sources. Environmental noise and reflections are monitored through system checks.

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 13 of 47

VI. Deviation from C63.19 Test Procedure

Non-conducted RF connection due to inaccessible RF ports.

VII. Air Interface Technologies Tested

All air interfaces which support voice capabilities over a managed CMRS or pre-installed OTT VoIP applications were tested for T-coil unless otherwise noted. See Table 2-1 for more details regarding which modes were tested.

VIII. Wireless Device Channels and Frequencies

1. 4G (LTE) Modes

The middle channel for every band and bandwidth combination was tested for each probe orientation. The band and bandwidth combination from each probe orientation resulting in the worst-case SNNR was additionally tested using low and high channels for that band and bandwidth combination. Low-mid and mid-high channels are additionally tested for LTE TDD. See Tables 6-2 to 6-7 for LTE bandwidths and channels.

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 14 of 47

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REV 3.3.M
08/13/2019

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IX. Test Flow

The flow diagram below was followed (From C63.19):

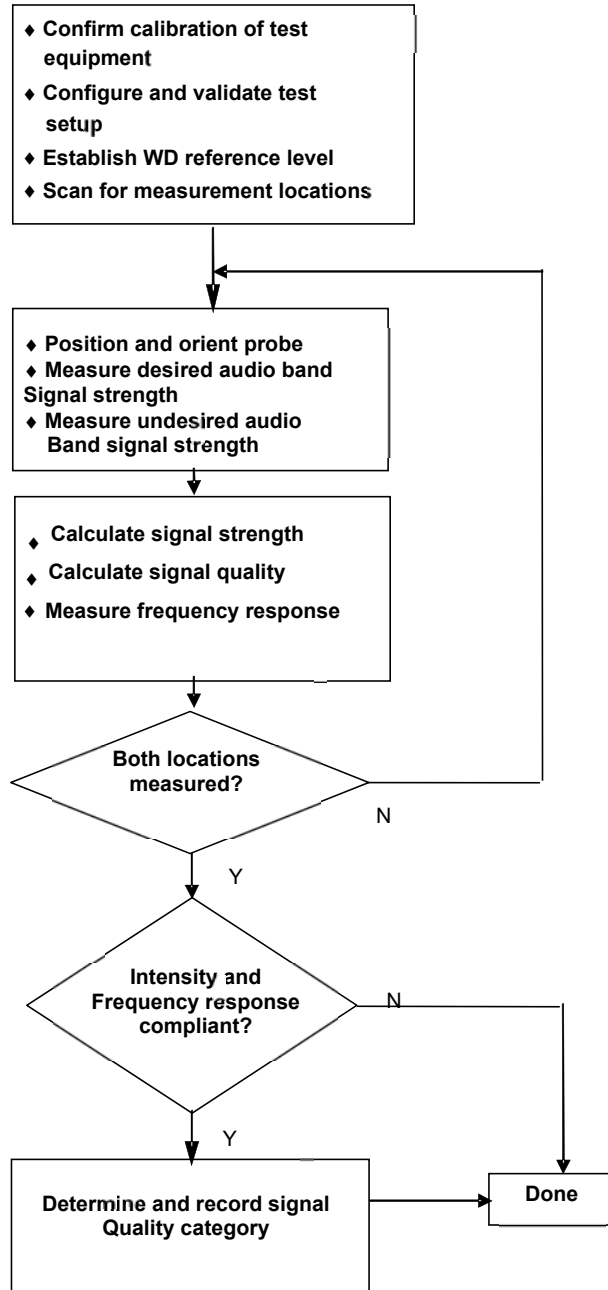


Figure 4-13
C63.19 T-Coil Signal Test Process

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 15 of 47

5. VOLTE TEST SYSTEM SETUP AND DUT CONFIGURATION

I. Test System Setup for VoLTE over IMS T-coil Testing

1. Equipment Setup

The general test setup used for VoLTE over IMS is shown below. The callbox used when performing VoLTE over IMS T-coil measurements is a CMW500. The Data Application Unit (DAU) of the CMW500 was used to simulate the IP Multimedia Subsystem (IMS) server.

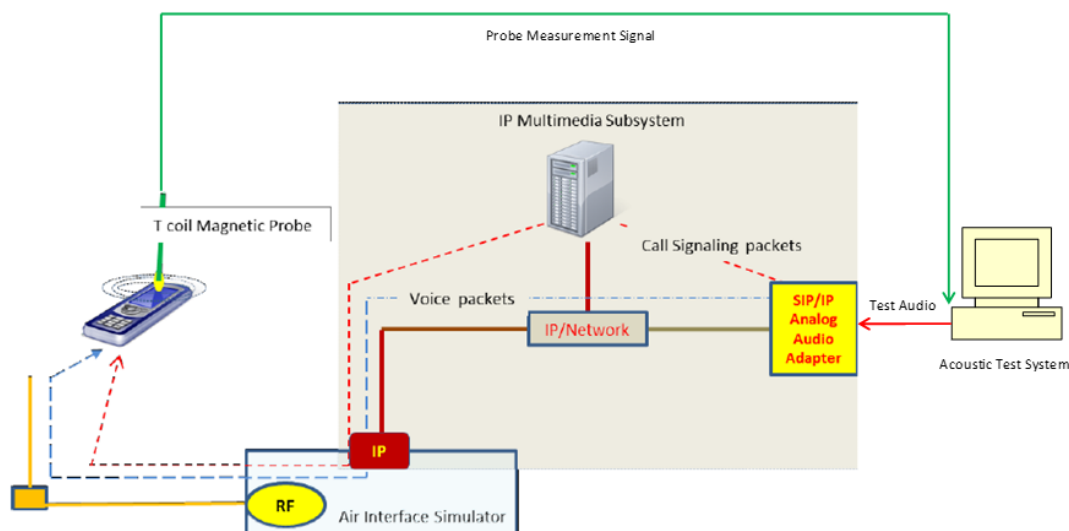


Figure 5-1
Test Setup for VoLTE over IMS T-Coil Measurements

2. Audio Level Settings

According to the July 2012 interpretations by the C63 Committee regarding the appropriate audio levels to be used for VoLTE over IMS T-coil testing, -16dBm0 shall be used for the normal speech input level*. The CMW500 base station simulator was manually configured to ensure that the settings for speech input and full scale levels resulted in the -16dBm0 speech input level to the DUT for the VoLTE over IMS connection.

* http://c63.org/documents/misc/posting/new_interpretations.htm

FCC ID: A3LSMJ337P	PCTEST ENGINEERING LABORATORY, INC.	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 16 of 47

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REV 3.3.M

08/13/2019

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II. DUT Configuration for VoLTE over IMS T-coil Testing

1. Radio Configuration

An investigation was performed to determine the modulation and RB configuration to be used for testing. The effects of modulation and RB configuration were found to be independent of band and bandwidth; therefore, only one band and bandwidth were used for this investigation. 16QAM, 1RB, 99% RB offset was used for the testing as the worst-case configuration for the handset. See below table for SNNR comparison between different radio configurations:

Table 5-1
VoLTE over IMS SNNR by Radio Configuration

Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	ABM1 [dB(A/m)]	ABM2 [dB(A/m)]	SNNR [dB]
12	707.5	23095	10	QPSK	1	0	2.67	-54.15	56.82
12	707.5	23095	10	QPSK	1	25	2.78	-53.96	56.74
12	707.5	23095	10	QPSK	1	49	2.69	-52.07	54.76
12	707.5	23095	10	QPSK	25	0	2.84	-54.80	57.64
12	707.5	23095	10	QPSK	25	12	2.74	-55.99	58.73
12	707.5	23095	10	QPSK	25	25	2.47	-56.44	58.91
12	707.5	23095	10	QPSK	50	0	2.71	-55.77	58.48
12	707.5	23095	10	16QAM	1	0	2.72	-49.27	51.99
12	707.5	23095	10	16QAM	1	25	2.60	-49.70	52.30
12	707.5	23095	10	16QAM	1	49	2.53	-48.20	50.73
12	707.5	23095	10	16QAM	25	0	2.55	-54.14	56.69
12	707.5	23095	10	16QAM	25	12	2.67	-55.54	58.21
12	707.5	23095	10	16QAM	25	25	2.84	-55.48	58.32
12	707.5	23095	10	16QAM	50	0	2.73	-55.74	58.47

2. Codec Configuration

An investigation was performed to determine the audio codec configuration to be used for testing. The effects of codec configuration were found to be independent of band and bandwidth; therefore, only one band and bandwidth were used for this investigation. The WB AMR 6.60kbps setting was used for the audio codec on the CMW500 for VoLTE over IMS T-coil testing. See below table for comparisons between different codecs and codec data rates:

Table 5-2
AMR Codec Investigation – VoLTE over IMS

Codec Setting:	WB AMR 23.85kbps	WB AMR 6.60kbps	NB AMR 12.2kbps	NB AMR 4.75kbps	Orientation	Band / BW	Channel
ABM1 (dBA/m)	2.89	2.74	6.24	5.48	Axial	LTE B12 10MHz	23095
ABM2 (dBA/m)	-49.19	-49.00	-49.63	-49.56			
Frequency Response	Pass	Pass	Pass	Pass			
S+N/N (dB)	52.08	51.74	55.87	55.04			

- Mute on; Backlight off; Max Volume; Max Contrast
- TPC = "Max Power"

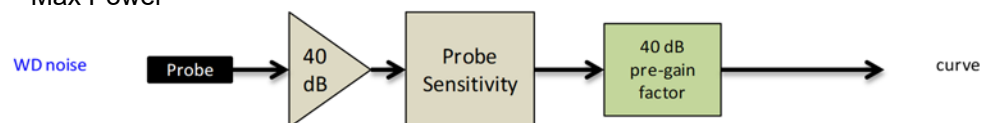


Figure 5-2
Audio Band Magnetic Curve Measurement Block Diagram

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 17 of 47

3. LTE TDD Uplink-Downlink Configuration Investigation for VoLTE over IMS

An investigation was performed to determine the worst-case Uplink-Downlink configuration for VoLTE over IMS T-Coil testing.

Per 3GPP TS 36.211, the total frame length for each TDD radio frame of length $T_f = 307200 \cdot T_s = 10$ ms, where T_s is a number of time units equal to $1/(15000 \times 2048)$ seconds. Additionally, each radio frame consists of 10 subframes, each of length $30720 \cdot T_s = 1$ ms, and subframes can be designated as uplink (U), downlink (D), or special subframe (S), depending on the Uplink-Downlink configuration as indicated in Table 4.2-2 of 3GPP TS 36.211. In the transmission duty factor calculation, the special subframe configuration with the shortest UpPTS duration within the special subframe is used and will be applied for measurement. From 3GPP TS 36.211 Table 4.2-1, the shortest UpPTS is $2192 \cdot T_s$ which occurs in the normal cyclic prefix and special subframe configuration 4.

See table below outlining the calculated transmission duty cycles for each Uplink-Downlink configuration:

Table 5-3
Uplink-Downlink Configurations for Type 2 Frame Structures

Uplink-downlink configuration	Downlink-to-Uplink Switch-point periodicity	Subframe number										Calculated Transmission Duty Cycle (%)
		0	1	2	3	4	5	6	7	8	9	
0	5 ms	D	S	U	U	U	D	S	U	U	U	61.4%
1	5 ms	D	S	U	U	D	D	S	U	U	D	41.4%
2	5 ms	D	S	U	D	D	D	S	U	D	D	21.4%
3	10 ms	D	S	U	U	U	D	D	D	D	D	30.7%
4	10 ms	D	S	U	U	D	D	D	D	D	D	20.7%
5	10 ms	D	S	U	D	D	D	D	D	D	D	10.7%
6	5 ms	D	S	U	U	U	D	S	U	U	D	51.4%

a. Power Class 3 Uplink-Downlink Configuration Investigation

Power class 3 was evaluated with the following radio configuration: channel 40620, 20MHz BW, 16QAM, 1RB, 0RB Offset. For Power Class 3, all configurations (0-6) are supported. The configuration which resulted in the worst SNNR was used for full testing. Uplink-Downlink configuration 1 was used as the worst-case configuration for Power Class 3 VoLTE over IMS T-Coil testing. See table below for the SNNR comparison between each Uplink-Downlink configuration:

Table 5-4
Power Class 3 VoLTE over IMS SNNR by UL-DL Configuration

Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	UL-DL Configuration	ABM1 [dB(A/m)]	ABM2 [dB(A/m)]	SNNR [dB]
2593.0	40620	20	16QAM	1	0	0	2.87	-40.85	43.72
2593.0	40620	20	16QAM	1	0	1	2.77	-40.62	43.39
2593.0	40620	20	16QAM	1	0	2	2.72	-41.18	43.90
2593.0	40620	20	16QAM	1	0	3	2.91	-42.43	45.34
2593.0	40620	20	16QAM	1	0	4	2.95	-42.28	45.23
2593.0	40620	20	16QAM	1	0	5	2.92	-42.61	45.53
2593.0	40620	20	16QAM	1	0	6	2.89	-41.48	44.37

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 18 of 47

b. Power Class 2 Uplink-Downlink Configuration Investigation

Power Class 2 was evaluated with the following radio configuration: channel 40620, 20MHz BW, 16QAM, 1RB, 0RB Offset. For Power Class 2, configurations 1-5 are supported. The configuration which resulted in the worst SNNR was used for full testing. Uplink-Downlink configuration 1 was used as the worst-case configuration for Power Class 2 VoLTE over IMS T-Coil testing. See table below for the SNNR comparison between each Uplink-Downlink configuration:

Table 5-5
Power Class 2 VoLTE over IMS SNNR by UL-DL Configuration

Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	UL-DL Configuration	ABM1 [dB(A/m)]	ABM2 [dB(A/m)]	SNNR [dB]
2593.0	40620	20	16QAM	1	0	1	2.53	-38.12	40.65
2593.0	40620	20	16QAM	1	0	2	2.99	-38.18	41.17
2593.0	40620	20	16QAM	1	0	3	2.77	-40.60	43.37
2593.0	40620	20	16QAM	1	0	4	2.99	-40.86	43.85
2593.0	40620	20	16QAM	1	0	5	2.96	-40.99	43.95

Note: LTE TDD B41 Power Class 2 only supports UL-DL configurations 1-5, not 0 or 6.

c. Conclusion

Per the investigations above, UL-DL Configuration 1 was used to evaluate both Power Class 3 and Power Class 2 VoLTE over IMS.

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 19 of 47

6. T-COIL TEST SUMMARY

Table 6-1
Consolidated Tabled Results

		Freq. Response Margin		Magnetic Intensity Verdict		FCC SNNR Verdict		Margin from FCC Limit (dB)	C63.19-2011 Rating
		8.3.2		8.3.1		8.3.4			
		Axial	Radial	Axial	Radial	Axial	Radial		
C63.19 Section									
LTE FDD	B12	PASS	NA	PASS	PASS	PASS	PASS	-29.96	T4
	B26	PASS	NA	PASS	PASS	PASS	PASS		
	B4	PASS	NA	PASS	PASS	PASS	PASS		
	B25	PASS	NA	PASS	PASS	PASS	PASS		
LTE TDD	B41 (PC3)	PASS	NA	PASS	PASS	PASS	PASS	-20.37	T4
	B41 (PC2)	PASS	NA	PASS	PASS	PASS	PASS		

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 20 of 47

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REV 3.3.M
08/13/2019

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I. Raw Handset Data

Table 6-2
Raw Data Results for LTE B12

Mode	Orientation	Bandwidth	Channel	ABM1 [dB(A/m)]	ABM2 [dB(A/m)]	Ambient Noise [dB(A/m)]	Frequency Response Margin (dB)	S+N/N (dB)	FCC Limit (dB)	Margin from FCC Limit (dB)	C63.19-2011 Rating	Test Coordinates
LTE Band 12	Axial	10MHz	23095	2.64	-48.03	-61.30	1.19	50.67	20.00	-30.67	T4	2.6, 2.4
		5MHz	23095	2.85	-47.54		1.26	50.39	20.00	-30.39	T4	
		3MHz	23095	2.85	-47.88		1.36	50.73	20.00	-30.73	T4	
		1.4MHz	23095	2.86	-48.03		1.27	50.89	20.00	-30.89	T4	
	Radial	10MHz	23095	-4.28	-55.08	-61.00	N/A	50.80	20.00	-30.80	T4	2.6, 1.6
		5MHz	23095	-4.55	-55.16			50.61	20.00	-30.61	T4	
		3MHz	23095	-4.29	-55.54			51.25	20.00	-31.25	T4	
		1.4MHz	23095	-4.13	-56.63			52.50	20.00	-32.50	T4	

Table 6-3
Raw Data Results for LTE B26

Mode	Orientation	Bandwidth	Channel	ABM1 [dB(A/m)]	ABM2 [dB(A/m)]	Ambient Noise [dB(A/m)]	Frequency Response Margin (dB)	S+N/N (dB)	FCC Limit (dB)	Margin from FCC Limit (dB)	C63.19-2011 Rating	Test Coordinates
LTE Band 26	Axial	15MHz	26865	2.62	-48.35	-61.30	1.14	50.97	20.00	-30.97	T4	2.6, 2.4
		10MHz	26865	2.72	-47.84		1.15	50.56	20.00	-30.56	T4	
		5MHz	26865	2.79	-47.76		1.21	50.55	20.00	-30.55	T4	
		3MHz	26865	2.74	-48.60		1.18	51.34	20.00	-31.34	T4	
		1.4MHz	26865	2.72	-48.03		1.10	50.75	20.00	-30.75	T4	
	Radial	15MHz	26865	-4.50	-55.57	-61.00	N/A	51.07	20.00	-31.07	T4	2.6, 1.6
		10MHz	26865	-4.45	-55.00			50.55	20.00	-30.55	T4	
		5MHz	26865	-4.19	-56.23			52.04	20.00	-32.04	T4	
		3MHz	26865	-4.29	-55.68			51.39	20.00	-31.39	T4	
		1.4MHz	26865	-4.30	-56.21			51.91	20.00	-31.91	T4	

Table 6-4
Raw Data Results for LTE B4

Mode	Orientation	Bandwidth	Channel	ABM1 [dB(A/m)]	ABM2 [dB(A/m)]	Ambient Noise [dB(A/m)]	Frequency Response Margin (dB)	S+N/N (dB)	FCC Limit (dB)	Margin from FCC Limit (dB)	C63.19-2011 Rating	Test Coordinates
LTE Band 4	Axial	20MHz	20300	2.42	-48.91	-61.30	1.02	51.33	20.00	-31.33	T4	2.6, 2.4
		20MHz	20175	2.48	-47.48		1.25	49.96	20.00	-29.96	T4	
		20MHz	20050	2.42	-50.09		1.17	52.51	20.00	-32.51	T4	
		15MHz	20175	2.56	-47.55		1.19	50.11	20.00	-30.11	T4	
		10MHz	20175	2.75	-48.00		1.19	50.75	20.00	-30.75	T4	
		5MHz	20175	2.70	-48.22		1.19	50.92	20.00	-30.92	T4	
		3MHz	20175	2.76	-48.66		1.19	51.42	20.00	-31.42	T4	
		1.4MHz	20175	2.48	-48.80		1.21	51.28	20.00	-31.28	T4	
	Radial	20MHz	20300	-4.18	-55.54	-61.00	N/A	51.36	20.00	-31.36	T4	2.6, 1.6
		20MHz	20175	-4.16	-54.24			50.08	20.00	-30.08	T4	
		20MHz	20050	-4.31	-56.93			52.62	20.00	-32.62	T4	
		15MHz	20175	-4.40	-55.14			50.74	20.00	-30.74	T4	
		10MHz	20175	-4.18	-55.76			51.58	20.00	-31.58	T4	
		5MHz	20175	-4.44	-56.26			51.82	20.00	-31.82	T4	
		3MHz	20175	-4.47	-55.77			51.30	20.00	-31.30	T4	
		1.4MHz	20175	-4.38	-56.81			52.43	20.00	-32.43	T4	

Table 6-5
Raw Data Results for LTE B25

Mode	Orientation	Bandwidth	Channel	ABM1 [dB(A/m)]	ABM2 [dB(A/m)]	Ambient Noise [dB(A/m)]	Frequency Response Margin (dB)	S+N/N (dB)	FCC Limit (dB)	Margin from FCC Limit (dB)	C63.19-2011 Rating	Test Coordinates
LTE Band 25	Axial	20MHz	26365	2.96	-47.25	-61.30	1.31	50.21	20.00	-30.21	T4	2.6, 2.4
		15MHz	26365	2.74	-48.13		1.24	50.87	20.00	-30.87	T4	
		10MHz	26365	2.70	-48.71		1.17	51.41	20.00	-31.41	T4	
		5MHz	26365	2.58	-49.22		1.14	51.80	20.00	-31.80	T4	
		3MHz	26365	2.46	-49.54		1.36	52.00	20.00	-32.00	T4	
		1.4MHz	26365	2.48	-48.99		1.18	51.47	20.00	-31.47	T4	
	Radial	20MHz	26365	-4.30	-55.08	-61.00	N/A	50.78	20.00	-30.78	T4	2.6, 1.6
		15MHz	26365	-4.03	-55.18			51.15	20.00	-31.15	T4	
		10MHz	26365	-4.21	-55.61			51.40	20.00	-31.40	T4	
		5MHz	26365	-4.05	-55.85			51.80	20.00	-31.80	T4	
		3MHz	26365	-4.41	-56.16			51.75	20.00	-31.75	T4	
		1.4MHz	26365	-4.18	-55.35			51.17	20.00	-31.17	T4	

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 21 of 47

Table 6-6
Raw Data Results for LTE B41 Power Class 3

Mode	Orientation	Bandwidth	Channel	ABM1 [dB(A/m)]	ABM2 [dB(A/m)]	Ambient Noise [dB(A/m)]	Frequency Response Margin (dB)	S+N/N (dB)	FCC Limit (dB)	Margin from FCC Limit (dB)	C63.19-2011 Rating	Test Coordinates
LTE Band 41	Axial	20MHz	40620	2.70	-41.03	-61.30	1.27	43.73	20.00	-23.73	T4	2.6, 2.4
		15MHz	40620	2.82	-41.45		1.16	44.27	20.00	-24.27	T4	
		10MHz	40620	2.68	-41.34		1.08	44.02	20.00	-24.02	T4	
		5MHz	40620	2.65	-41.67		1.23	44.32	20.00	-24.32	T4	
	Radial	20MHz	40620	-4.30	-54.95	-61.00	N/A	50.65	20.00	-30.65	T4	2.6, 1.6
		15MHz	40620	-4.28	-55.94			51.66	20.00	-31.66	T4	
		10MHz	40620	-4.43	-56.25			51.82	20.00	-31.82	T4	
		5MHz	40620	-4.17	-55.49			51.32	20.00	-31.32	T4	

Table 6-7
Raw Data Results for LTE B41 Power Class 2

Mode	Orientation	Bandwidth	Channel	ABM1 [dB(A/m)]	ABM2 [dB(A/m)]	Ambient Noise [dB(A/m)]	Frequency Response Margin (dB)	S+N/N (dB)	FCC Limit (dB)	Margin from FCC Limit (dB)	C63.19-2011 Rating	Test Coordinates
LTE Band 41	Axial	20MHz	40620	2.93	-37.90	-61.30	1.29	40.83	20.00	-20.83	T4	2.6, 2.4
		15MHz	40620	2.97	-37.92		1.08	40.89	20.00	-20.89	T4	
		10MHz	41490	2.95	-39.25		1.17	42.20	20.00	-22.20	T4	
		10MHz	41055	2.72	-39.44		1.23	42.16	20.00	-22.16	T4	
		10MHz	40620	2.95	-37.42		1.23	40.37	20.00	-20.37	T4	
		10MHz	40185	2.85	-38.35		1.28	41.20	20.00	-21.20	T4	
		10MHz	39750	2.87	-39.64		1.12	42.51	20.00	-22.51	T4	
		5MHz	40620	2.65	-38.02		1.21	40.67	20.00	-20.67	T4	
	Radial	20MHz	40620	-4.16	-53.16	-61.00	N/A	49.00	20.00	-29.00	T4	2.6, 1.6
		15MHz	40620	-4.21	-53.33			49.12	20.00	-29.12	T4	
		10MHz	41490	-4.18	-53.43			49.25	20.00	-29.25	T4	
		10MHz	41055	-4.21	-54.42			50.21	20.00	-30.21	T4	
		10MHz	40620	-4.33	-53.14			48.81	20.00	-28.81	T4	
		10MHz	40185	-4.26	-52.83			48.57	20.00	-28.57	T4	
		10MHz	39750	-4.17	-54.63			50.46	20.00	-30.46	T4	
		5MHz	40620	-4.31	-53.79			49.48	20.00	-29.48	T4	

II. Test Notes

A. General

1. Phone Condition: Mute on; Backlight off; Max Volume; Max Contrast
2. 'Radial' orientation refers to radial transverse.
3. Hearing Aid Mode (**Phone→Settings→Other Call Settings→Hearing aids**) was set to ON for Frequency Response compliance
4. Speech Signal: 3GPP2 Normal Test Signal
5. Bluetooth and WIFI were disabled while testing 4G modes.
6. The Margin from FCC limit column indicates a margin from the FCC limit for compliance (T4).

B. LTE FDD

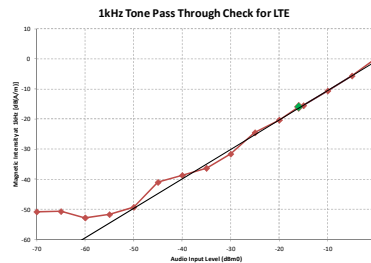
1. Power Configuration: TPC = "Max Power"
2. Radio Configuration: 16QAM, 1RB, 99% RB offset
3. Vocoder Configuration: WB AMR 6.60kbps
4. The worst-case band and bandwidth combination for each probe orientation is additionally tested on the low and high channels for those combinations. LTE Band 4 at 20MHz is the worst-case for the Axial and Radial probe orientation.

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 22 of 47

C. LTE TDD

1. Power Configuration: TPC = "Max Power"
2. Radio Configuration: 16QAM, 1RB, 99% RB offset
3. Power Class 3 Uplink-Downlink configuration: 1
4. Power Class 2 Uplink-Downlink configuration: 1
5. Vocoder Configuration: WB AMR 6.60kbps
6. The worst-case band and bandwidth combination for each probe orientation is additionally tested on the low, low-mid, high-mid, and high channels for those combinations. LTE Band 41 (Power Class 2) at 10MHz is the worst-case for the Axial and Radial probe orientation.

III. 1 kHz Vocoder Application Check



This model was verified to be within the linear region for ABM1 measurements at -16 dBm0 for VoLTE over IMS. This measurement was taken in the axial configuration above the maximum location.

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 23 of 47

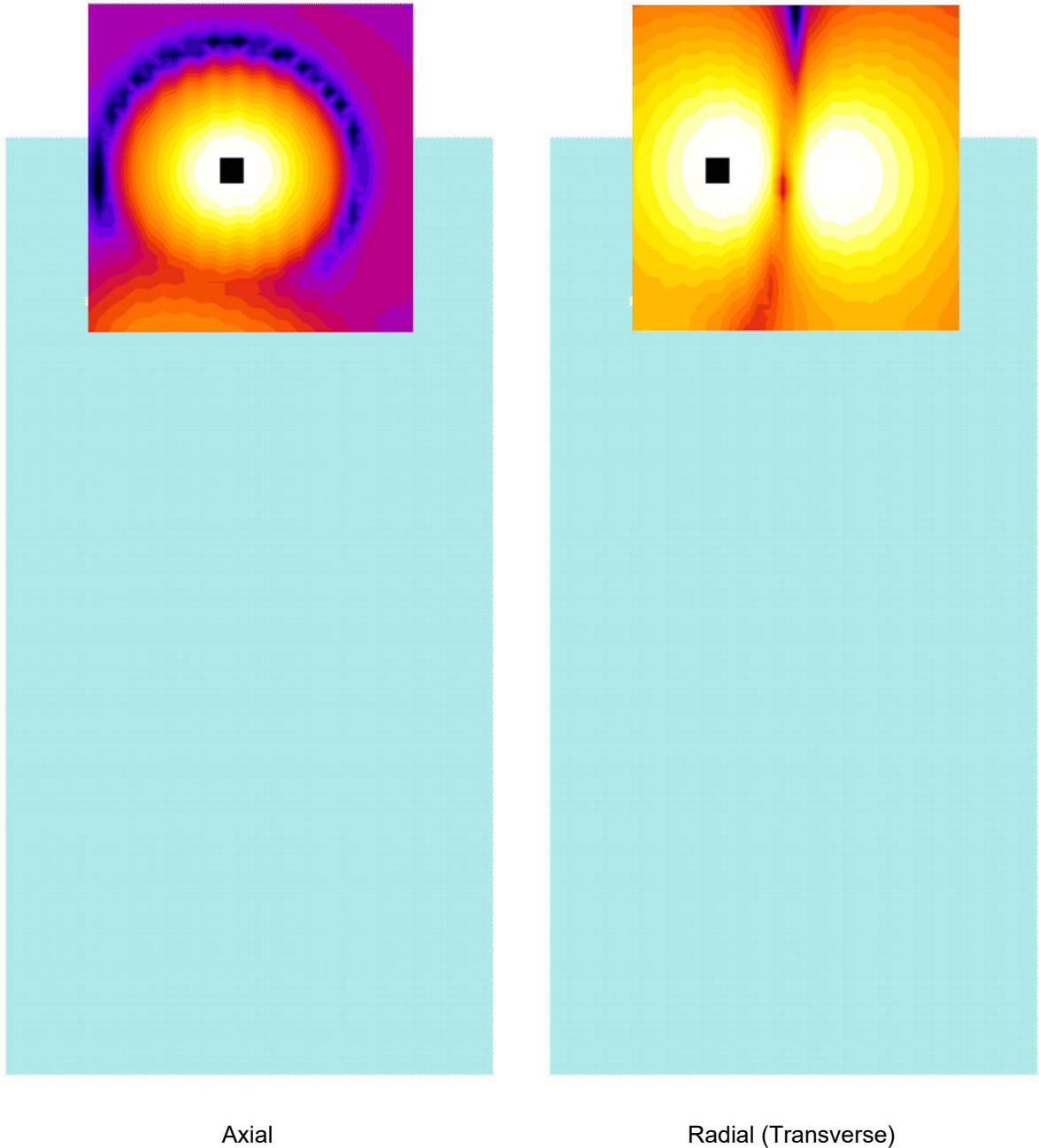
IV. T-Coil Validation Test Results

Table 6-8
Helmholtz Coil Validation Table of Results

Item	Target	Result	Verdict
Axial			
Magnetic Intensity, -10 dBA/m	$-10 \pm 0.5 \text{ dB}$	-9.771	PASS
Environmental Noise	< -58 dBA/m	-61.30	PASS
Frequency Response, from limits	> 0 dB	0.50	PASS
Radial			
Magnetic Intensity, -10 dBA/m	$-10 \pm 0.5 \text{ dB}$	-10.077	PASS
Environmental Noise	< -58 dBA/m	-61.00	PASS
Frequency Response, from limits	> 0 dB	0.70	PASS

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset	Page 24 of 47	

V. ABM1 Magnetic Field Distribution Scan Overlays



Axial

Radial (Transverse)

Figure 6-1
T-Coil Scan Overlay Magnetic Field Distributions

Notes:

1. Final measurement locations are indicated by a cursor on the contour plots.
2. See Test Setup Photographs for actual WD overlay.

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 25 of 47

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7. MEASUREMENT UNCERTAINTY

Table 7-1
Uncertainty Estimation Table

Contribution	Data +/- %	Data +/- dB	Data Type	Probability distribution	Divisor	Standard uncertainty	Standard Uncertainty (dB)
ABM Noise	7.0%	0.29	Std. Dev.	Normal k=1	1.00	7.0%	
RF Reflections	4.7%	0.20	Specification	Rectangular	1.73	2.7%	
Reference Signal Level	12.2%	0.50	Specification	Rectangular	1.73	7.0%	
Positioning Accuracy	10.0%	0.41	Uncertainty	Rectangular	1.73	5.8%	
Probe Coil Sensitivity	12.2%	0.50	Specification	Rectangular	1.73	7.0%	
Probe Linearity	2.4%	0.10	Std. Dev.	Normal k=1	1.00	2.4%	
Cable Loss	2.8%	0.12	Specification	Rectangular	1.73	1.6%	
Frequency Analyzer	5.0%	0.21	Specification	Rectangular	1.73	2.9%	
System Repeatability	5.0%	0.21	Std. Dev.	Normal k=1	1.00	5.0%	
WD Repeatability	9.0%	0.37	Std. Dev.	Normal k=1	1.00	9.0%	
Positioner Accuracy	1.0%	0.04	Specification	Rectangular	1.73	0.6%	
Combined standard uncertainty, uc (k=1)						17.7%	0.71
Expanded uncertainty (k=2), 95% confidence level						35.3%	1.31

Notes:

1. Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297.
2. All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81 and NIST Tech Note 1297 and UKAS M3003.

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurement uncertainty. Another component of the overall uncertainty is based on the variability of repeated measurements (so-called Type A uncertainty). This may mean that the Hearing Aid compatibility tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurement results with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 26 of 47

8. EQUIPMENT LIST

**Table 8-1
Equipment List**

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
Control Company	4040	Temperature / Humidity Monitor	2/28/2018	Biennial	2/28/2020	150761911
Dell	Latitude E6540	SoundCheck Acoustic Analyzer Laptop	9/6/2018	Biennial	9/6/2020	2655082910
Listen	SoundConnect	Microphone Power Supply	9/6/2018	Biennial	9/6/2020	0899-PS150
RME	Fireface UC	Soundcheck Acoustic Analyzer External Audio Interface	9/6/2018	Biennial	9/6/2020	23792992
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	1/30/2019	Annual	1/30/2020	162125
Rohde & Schwarz	CMW500	Radio Communication tester	5/17/2019	Annual	5/17/2020	128635
Seekonk	NC-100	Torque Wrench (8" lb)	5/10/2018	Biennial	5/10/2020	21053
TEM	Axial T-Coil Probe	Axial T-Coil Probe	9/19/2018	Biennial	9/19/2020	TEM-1123
TEM	Radial T-Coil Probe	Radial T-Coil Probe	9/19/2018	Biennial	9/19/2020	TEM-1129
TEM	Helmholtz Coil	Helmholtz Coil	10/10/2018	Biennial	10/10/2020	SBI 1052
TEM		HAC System Controller with Software	N/A		N/A	N/A
TEM		HAC Positioner	N/A		N/A	N/A

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 27 of 47

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9. TEST DATA

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset	Page 28 of 47	

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PCTEST Hearing-Aid Compatibility Facility

DUT: HH Coil – SN: SBI 1052

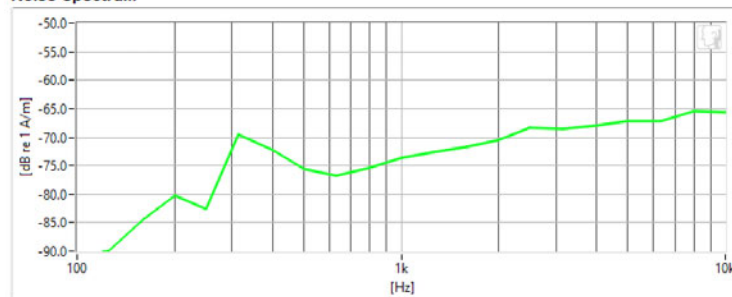
Type: HH Coil
Serial: SBI 1052

Measurement Standard: ANSI C63.19-2011

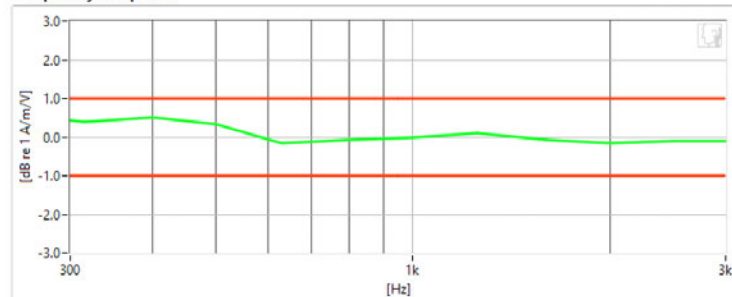
Equipment:

- Probe: Axial T-Coil Probe – SN: TEM-1123; Calibrated: 09/19/2018
- Helmholtz Coil – SN: SBI 1052; Calibrated: 10/10/2018

Noise Spectrum



Frequency Response



Results

Verification 1kHz Intensity	-9.771 dB	✓	Max/Min	-9.5/-10.5
Verification ABM2	-61.3 dB	✓	Maximum	-58.0
Frequency Response Margin	500m dB	✓	Tolerance curves	Aligned Data

PCTEST 2019

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 29 of 47

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PCTEST Hearing-Aid Compatibility Facility

DUT: HH Coil – SN: SBI 1052

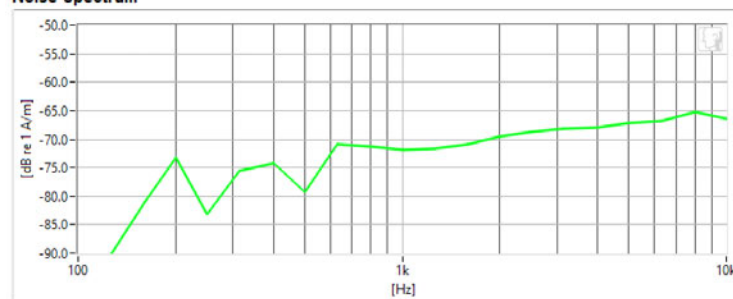
Type: HH Coil
Serial: SBI 1052

Measurement Standard: ANSI C63.19-2011

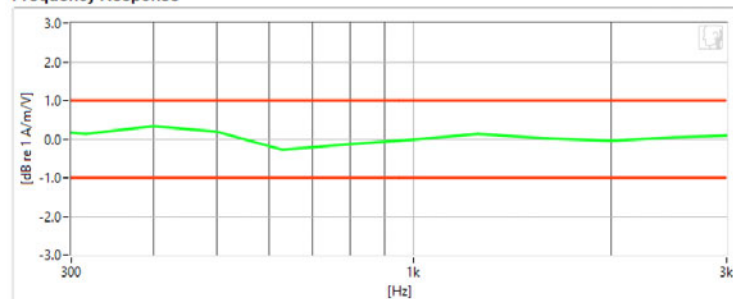
Equipment:

- Probe: Radial T-Coil Probe – SN: TEM-1129; Calibrated: 09/19/2018
- Helmholtz Coil – SN: SBI 1052; Calibrated: 10/10/2018

Noise Spectrum



Frequency Response



Results

Verification 1kHz Intensity	-10.077 dB	✓	Max/Min	-9.5/-10.5
Verification ABM2	-61 dB	✓	Maximum	-58.0
Frequency Response Margin	700m dB	✓	Tolerance curves	Aligned Data

PCTEST 2019

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 30 of 47

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PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMJ337P

Type: Portable Handset
Serial: 58046

Measurement Standard: ANSI C63.19-2011

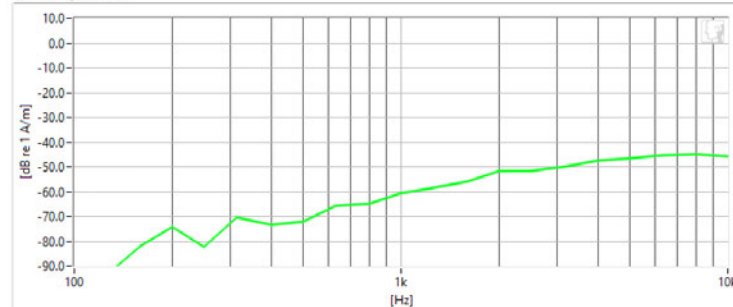
Equipment:

- Probe: Axial T-Coil Probe – SN: TEM-1123; Calibrated: 09/19/2018

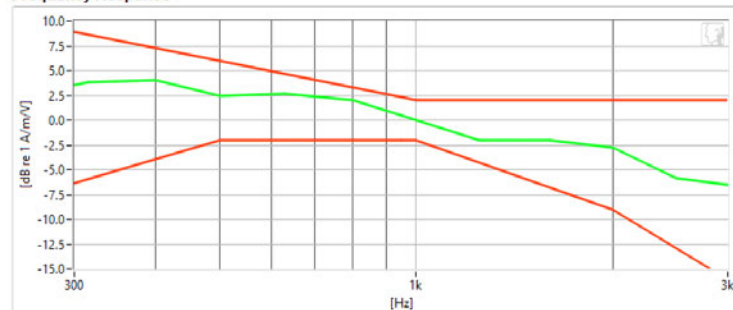
Test Configuration:

- Mode: LTE FDD Band 4
- Bandwidth: 20MHz
- Channel: 20175
- Speech Signal: 3GPP2 Normal Test Signal

Noise Spectrum



Frequency Response



Results

ABM1	2.48 dB	✓	Minimum	-18.0
ABM2	-47.48 dB	✓	Maximum	0.0
SNNR	49.96 dB	✓	Minimum	20.0
Aligned Response - Normal	1.25 dB	✓	Tolerance curves	Aligned Data

PCTEST 2019

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 31 of 47

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PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMJ337P

Type: Portable Handset
Serial: 58046

Measurement Standard: ANSI C63.19-2011

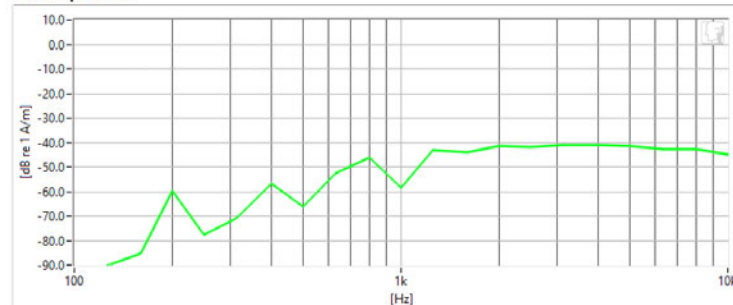
Equipment:

- Probe: Axial T-Coil Probe – SN: TEM-1123; Calibrated: 09/19/2018

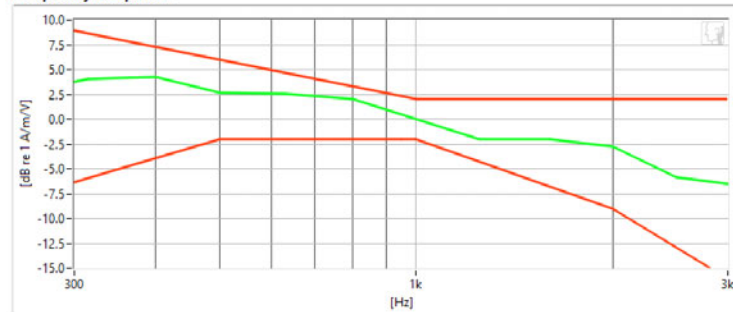
Test Configuration:

- Mode: LTE TDD Band 41 (PC2)
- Bandwidth: 10MHz
- Channel: 40620
- Speech Signal: 3GPP2 Normal Test Signal

Noise Spectrum



Frequency Response



Results

ABM1	2.95 dB	✓	Minimum	-18.0
ABM2	-37.42 dB	✓	Maximum	0.0
SNNR	40.37 dB	✓	Minimum	20.0
Aligned Response - Normal	1.23 dB	✓	Tolerance curves	Aligned Data

PCTEST 2019

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 32 of 47

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PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMJ337P

Type: Portable Handset

Serial: 58046

Measurement Standard: ANSI C63.19-2011

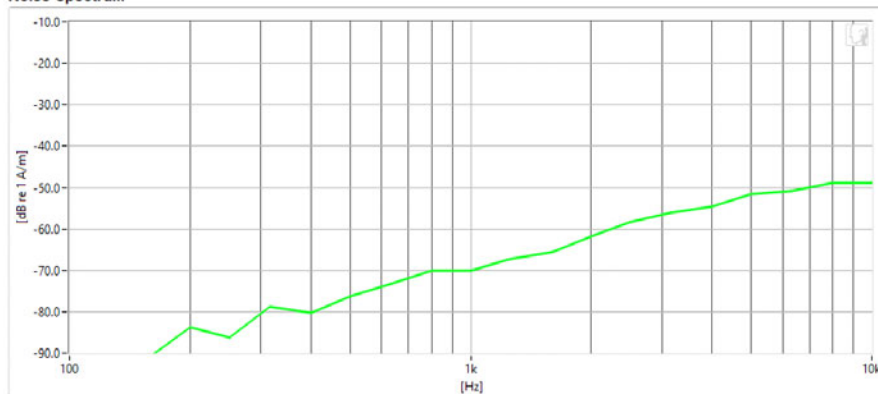
Equipment:

- Probe: Radial T-Coil Probe – SN: TEM-1129; Calibrated: 09/19/2018

Test Configuration:

- Mode: LTE FDD Band 4
- Bandwidth: 20MHz
- Channel: 20175

Noise Spectrum



Results

ABM1	-4.16 dB	✓	Minimum	-18.0
ABM2	-54.24 dB	✓	Maximum	0.0
SNNR	50.08 dB	✓	Minimum	20.0

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FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 33 of 47

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PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMJ337P

Type: Portable Handset
Serial: 58046

Measurement Standard: ANSI C63.19-2011

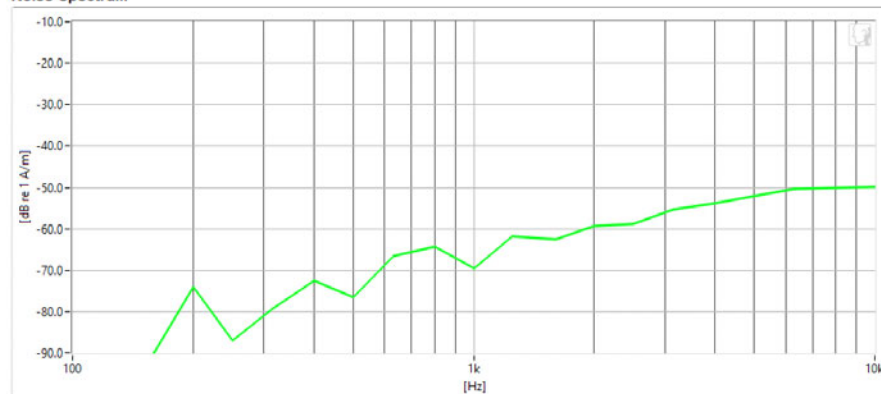
Equipment:

- Probe: Radial T-Coil Probe – SN: TEM-1129; Calibrated: 09/19/2018

Test Configuration:

- Mode: LTE TDD Band 41 (PC2)
- Bandwidth: 10MHz
- Channel: 40185

Noise Spectrum



Results

ABM1	-4.26 dB	✓	Minimum	-18.0
ABM2	-52.84 dB	✓	Maximum	0.0
SNNR	48.57 dB	✓	Minimum	20.0

PCTEST 2019

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 34 of 47

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10. CALIBRATION CERTIFICATES

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset	Page 35 of 47	

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West Caldwell Calibration Laboratories Inc.

Certificate of Calibration

for

AXIAL T COIL PROBE

Manufactured by: TEM CONSULTING LP
Model No: AXIAL T COIL PROBE
Serial No: TEM-1123
Calibration Recall No: 29156

Submitted By:

Customer: Andrew Harwell
Company: PCTest Engineering Lab
Address: 6660-B Dobbin Road
Columbia MD 21045

The subject instrument was calibrated to the indicated specification using standards traceable to the National Institute of Standards and Technology or to accepted values of natural physical constants. This document certifies that the instrument met the following specification upon its return to the submitter.

West Caldwell Calibration Laboratories Procedure No. AXIAL T C TEM C

Upon receipt for Calibration, the instrument was found to be:

Within (X)

tolerance of the indicated specification. See attached Report of Calibration.
The information supplied relates to the calibrated item listed above.

West Caldwell Calibration Laboratories' calibration control system meets the requirements, ISO 10012-1 MIL-STD-45662A, ANSI/NCSS Z540-1, IEC Guide 25, ISO 9001:2008 and ISO 17025.

Note: With this Certificate, Report of Calibration is included.

Approved by: *Fe*

Calibration Date: 19-Sep-18

Felix Christopher (QA Mgr.)

Certificate No: 29156 -2

ISO/IEC 17025:2005

QA Doc. #1051 Rev. 2.0 10/1/01

Certificate Page 1 of 1

**West Caldwell
Calibration
Laboratories, Inc.**
uncompromised calibration
1575 State Route 96, Victor, NY 14564, U.S.A.



Calibration Lab. Cert. # 1533.01

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 36 of 47

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REPORT OF CALIBRATION

for

TEM Consulting LP Axial T Coil Probe
Company: PCTest Engineering Lab

Model No.: Axial T Coil Probe

Serial No.: TEM-1123
I. D. No.: XXXX

Calibration results:

Probe Sensitivity measured with Helmholtz Coil

<i>Helmholtz Coil;</i>		
the number of turns on each coil;	10	No.
the radius of each coil, in meters;	0.204	m
the current in the coils, in amperes.;	0.08	A
<i>Helmholtz Coil Constant;</i>	7.09	A/m/V
<i>Helmholtz Coil magnetic field;</i>	5.95	A/m

Before & after data same: ...X...

Laboratory Environment:

Ambient Temperature:	22.7	°C
Ambient Humidity:	52.1	% RH
Ambient Pressure:	99.326	kPa

Calibration Date: 19-Sep-2018

Calibration Due:

Report Number: 29156 -2

Control Number: 29156

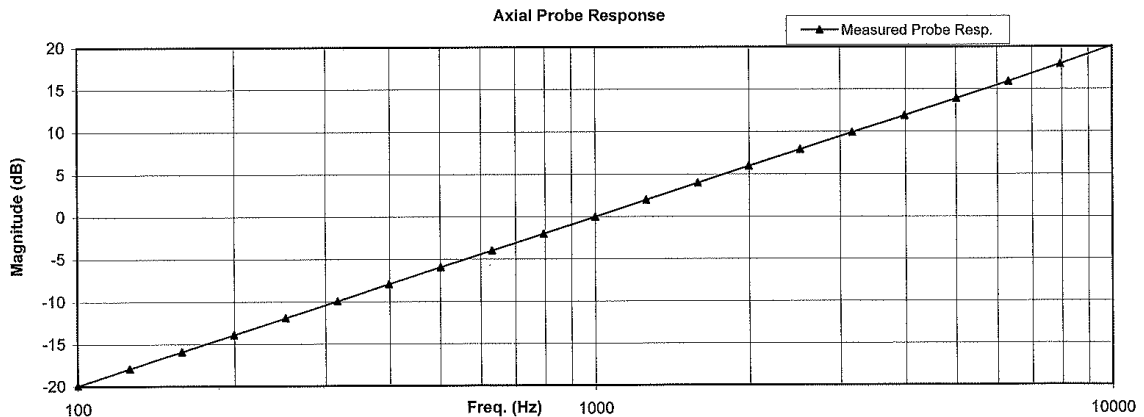
Probe Sensitivity at	1000	Hz.
was	-59.89	dBV/A/m
	1.013	mV/A/m
Probe resistance	903	Ohms

The above listed instrument meets or exceeds the tested manufacturer's specifications.

This Calibration is traceable through NIST test numbers: 683/284413-14

The expanded uncertainty of calibration: 0.30dB at 95% confidence level with a coverage factor of k=2.

Graph represents Probes Frequency Response.



The above listed instrument was checked using calibration procedure documented in West Caldwell

Calibration Laboratories Inc. procedure :

Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCATEMC

Calibration was performed by West Caldwell Calibration Laboratories Inc. under Operating Procedures

intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NC SL Z540-1, (MIL-STD-45662A) and ISO 9001:2008, ISO 17025

Cal. Date: 19-Sep-2018

Measurements performed by:

Calibrated on WCCL system type 9700

James Zhu

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Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCATEMC

FCC ID: A3LSMJ337P	PCTEST ENGINEERING LABORATORY, INC.	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 37 of 47

HCATEMC_TEM-1123_Sep-19-2018

West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564

Tel. (585) 586-3900 FAX (585) 586-4327

Calibration Data Record

TEM Consulting LP Axial T Coil Probe
Company: PCTest Engineering Lab

for
Model No.: Axial T Coil Probe

Serial No.: TEM-1123

Test	Function	Tolerance	Measured values		
			Before	Out	Remarks
1.0	Probe Sensitivity at	1000 Hz. dBV/A/m	-59.89		
2.0	Probe Level Linearity	dB			
		6	6.03		
		0	0.00		
		-6	-6.03		
3.0	Probe Frequency Response	Ref. (0 dB)	-12.05		
		Hz			
		100	-19.9		
		126	-17.9		
		158	-15.9		
		200	-13.9		
		251	-11.9		
		316	-9.9		
		398	-7.9		
		501	-6.0		
		631	-4.0		
		794	-2.0		
		Ref. (0 dB)	0.0		
		1000	2.0		
		1259	4.0		
		1585	5.9		
		1995	7.9		
		2512	9.9		
		3162	11.9		
		3981	13.9		
		5012	15.9		
		6310	18.0		
		7943	20.1		
		10000			

Instruments used for calibration:			Date of Cal.	Traceability No.	Due Date
HP	34401A	S/N US360641	25-Jul-2018	,287708	25-Jul-2019
HP	34401A	S/N US361024	25-Jul-2018	,287708	25-Jul-2019
HP	33120A	S/N US360437	25-Jul-2018	,287708	25-Jul-2019
B&K	2133	S/N 1583254	25-Jul-2018	683/284413-14	25-Jul-2019

Cal. Date: 19-Sep-2018
Calibrated on WCCL system type 9700

Tested by: James Zhu

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Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCATEMC

Page 2 of 2

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset	Page 38 of 47	

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REV 3.3.M
08/13/2019

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West Caldwell Calibration Laboratories Inc.

Certificate of Calibration

for

RADIAL T COIL PROBE

Manufactured by: TEM CONSULTING LP
Model No: RADIAL T COIL PROBE
Serial No: TEM-1129
Calibration Recall No: 29156

Submitted By:

Customer: Andrew Harwell
Company: PCTest Engineering Lab
Address: 6660-B Dobbin Road
Columbia MD 21045

The subject instrument was calibrated to the indicated specification using standards traceable to the National Institute of Standards and Technology or to accepted values of natural physical constants. This document certifies that the instrument met the following specification upon its return to the submitter.

West Caldwell Calibration Laboratories Procedure No. RADIAL T TEM C

Upon receipt for Calibration, the instrument was found to be:

Within (X)

tolerance of the indicated specification. See attached Report of Calibration.

The information supplied relates to the calibrated item listed above.

West Caldwell Calibration Laboratories' calibration control system meets the requirements, ISO 10012-1 MIL-STD-45662A, ANSI/NCSL Z540-1, IEC Guide 25, ISO 9001:2008 and ISO 17025.

Note: With this Certificate, Report of Calibration is included.

Approved by: FC

Calibration Date: 19-Sep-18

Felix Christopher (QA Mgr.)

Certificate No: 29156 -1

ISO/IEC 17025:2005

QA Doc. #1051 Rev. 2.0 10/1/01

Certificate Page 1 of 1

West Caldwell Calibration Laboratories, Inc.
uncompromised calibration
1575 State Route 96, Victor, NY 14564, U.S.A.



Calibration Lab. Cert. # 1533.01

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 39 of 47

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REV 3.3.M
08/13/2019

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REPORT OF CALIBRATION

for

TEM Consulting LP Radial T Coil Probe
Company: PCTest Engineering Lab

Model No.: Radial T Coil Probe

Serial No.: TEM-1129
I. D. No.: XXXX

Calibration results:

Probe Sensitivity measured with Helmholtz Coil

<i>Helmholtz Coil;</i>		
the number of turns on each coil;	10	No.
the radius of each coil, in meters;	0.204	m
the current in the coils, in amperes.;	0.08	A
<i>Helmholtz Coil Constant;</i>	7.09	A/m/V
<i>Helmholtz Coil magnetic field;</i>	5.95	A/m

Before & after data same: ...X...

Laboratory Environment:	
Ambient Temperature:	22.7 °C
Ambient Humidity:	52.1 % RH
Ambient Pressure:	99.326 kPa
Calibration Date:	19-Sep-2018
Re-calibration Due:	
Report Number:	29156 -1
Control Number:	29156

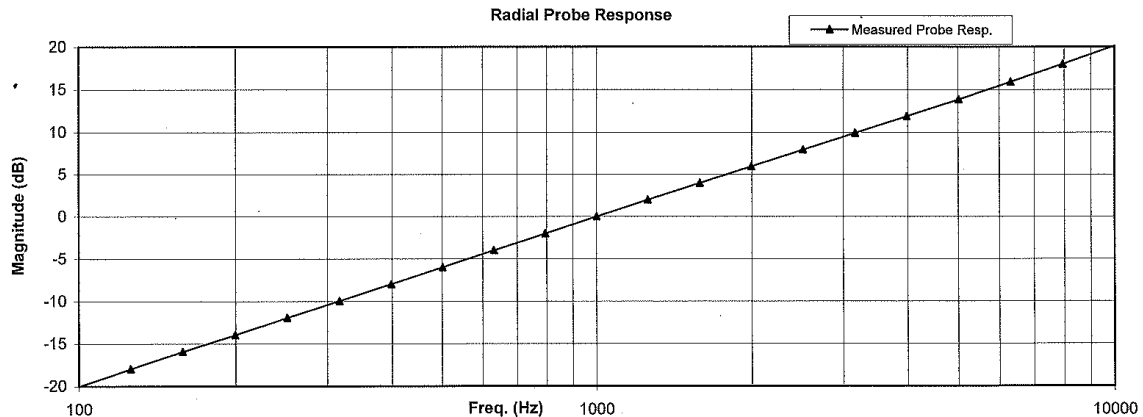
Probe Sensitivity at	1000	Hz.
was	-60.37	dBV/A/m
	0.958	mV/A/m
Probe resistance	886	Ohms

The above listed instrument meets or exceeds the tested manufacturer's specifications.

This Calibration is traceable through NIST test numbers: 683/284413-14

The expanded uncertainty of calibration: 0.30dB at 95% confidence level with a coverage factor of k=2.

Graph represents Probes Frequency Response.



The above listed instrument was checked using calibration procedure documented in West Caldwell

Calibration Laboratories Inc. procedure :

Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCRTEMC

Calibration was performed by West Caldwell Calibration Laboratories Inc. under Operating Procedures

intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCCL Z540-1, (MIL-STD-45662A) and ISO 9001:2008, ISO 17025

Cal. Date: 19-Sep-2018

Measurements performed by:

Calibrated on WCCL system type 9700

James Zhu

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Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCRTEMC

FCC ID: A3LSMJ337P	PCTEST ENGINEERING LABORATORY, INC.	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 40 of 47

HCRTEMC_TEM-1129_Sep-19-2018

West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564
Tel. (585) 586-3900 FAX (585) 586-4327

Calibration Data Record

TEM Consulting LP Radial T Coil Probe
Company: PCTest Engineering Lab

for
Model No.: Radial T Coil Probe

Serial No.: TEM-1129

Test	Function	Tolerance	Measured values		
			Before	Out	Remarks
1.0	Probe Sensitivity at	1000 Hz. dBV/A/m	-60.37		
2.0	Probe Level Linearity	dB			
		6	6.03		
		0	0.00		
		-6	-6.03		
3.0	Probe Frequency Response	Ref. (0 dB)	-12.05		
		Hz			
		100	-20.0		
		126	-17.9		
		158	-15.9		
		200	-14.0		
		251	-12.0		
		316	-10.0		
		398	-8.0		
		501	-6.0		
		631	-4.0		
		794	-2.0		
		Ref. (0 dB)	1000	0.0	
		1259	2.0		
		1585	4.0		
		1995	6.0		
		2512	7.9		
		3162	9.9		
		3981	11.9		
		5012	13.9		
		6310	15.9		
		7943	18.0		
		10000	20.1		

Instruments used for calibration:			Date of Cal.	Traceability No.	Due Date
HP	34401A	S/N US360641	25-Jul-2018	287708	25-Jul-2019
HP	34401A	S/N US361024	25-Jul-2018	287708	25-Jul-2019
HP	33120A	S/N US360437	25-Jul-2018	287708	25-Jul-2019
B&K	2133	S/N 1583254	25-Jul-2018	683/284413-14	25-Jul-2019

Cal. Date: 19-Sep-2018

Tested by: James Zhu

Calibrated on WCCL system type 9700

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Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCRTEMC

Page 2 of 2

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset	Page 41 of 47	

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REV 3.3.M
08/13/2019

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11. CONCLUSION

The measurements indicate that the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 42 of 47

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REV 3.3.M
08/13/2019

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FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset		Page 43 of 47

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REV 3.3.M

08/13/2019

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FCC ID: A3LSMJ337P		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1910220168-01.A3L	Test Dates: 10/28/2019 - 10/29/2019	DUT Type: Portable Handset	Page 44 of 47	

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08/13/2019

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